

ANNEX E PROBE CALIBRATION CERTIFICATE

Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
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S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Client **TMC China**

Certificate No: **ES3DV3-3149_Sep09**

CALIBRATION CERTIFICATE


Object	ES3DV3-SN: 3149
Calibration procedure(s)	QA CAL-01.v6 Calibration procedure for dosimetric E-field probes
Calibration date:	September 25, 2009
Condition of the calibrated item	In Tolerance

This calibration certify documents the traceability to national standards, which realize the physical units of measurements(SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.
All calibrations have been conducted at an environment temperature (22±3)°C and humidity<70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID#	Cal Data (Calibrated by, Certification NO.)	Scheduled Calibration
Power meter E4419B	GB41293874	5-May-09 (METAS, NO. 251-00388)	May-10
Power sensor E4412A	MY41495277	5-May-09 (METAS, NO. 251-00388)	May-10
Reference 3 dB Attenuator	SN:S5054 (3c)	10-Aug-09 (METAS, NO. 251-00403)	Aug-10
Reference 20 dB Attenuator	SN:S5086 (20b)	3-May-09 (METAS, NO. 251-00389)	May-10
Reference 30 dB Attenuator	SN:S5129 (30b)	10-Aug-09 (METAS, NO. 251-00404)	Aug-10
DAE4	SN:617	10-Jun-09 (SPEAG, NO.DAE4-907_Jun09)	Jun-10
Reference Probe ES3DV2	SN: 3013	12-Jan-09 (SPEAG, NO. ES3-3013_Jan09)	Jan-10

Secondary Standards	ID#	Check Data (in house)	Scheduled Calibration
RF generator HP8648C	US3642U01700	4-Aug-99(SPEAG, in house check Oct-07)	In house check: Oct-09
Network Analyzer HP 8753E	US37390585	18-Oct-01(SPEAG, in house check Nov-07)	In house check: Nov-09

Name	Function	Signature
Calibrated by: Katja Pokovic	Technical Manager	

Approved by: Niels Kuster	Quality Manager	
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Issued: **September 25, 2009**

This calibration certificate shall not be reported except in full without written approval of the laboratory.

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Accreditation No.: SCS 108

Glossary:

TSL	tissue simulating liquid
NORM _{x,y,z}	sensitivity in free space
ConF	sensitivity in TSL / NORM _{x,y,z}
DCP	diode compression point
Polarization φ	φ rotation around probe axis
Polarization ϑ	ϑ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., $\vartheta = 0$ is normal to probe axis

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005

Methods Applied and Interpretation of Parameters:

- *NORM_{x,y,z}*: Assessed for E-field polarization $\vartheta = 0$ ($f \leq 900$ MHz in TEM-cell; $f > 1800$ MHz: R22 waveguide). *NORM_{x,y,z}* are only intermediate values, i.e., the uncertainties of *NORM_{x,y,z}* does not effect the E^2 -field uncertainty inside TSL (see below *ConvF*).
- *NORM(f)_{x,y,z}* = *NORM_{x,y,z}* * *frequency_response* (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of *ConvF*.
- *DCP_{x,y,z}*: DCP are numerical linearization parameters assessed based on the data of power sweep (no uncertainty required). DCP does not depend on frequency nor media.
- *ConvF and Boundary Effect Parameters*: Assessed in flat phantom using E-field (or Temperature Transfer Standard for $f \leq 800$ MHz) and inside waveguide using analytical field distributions based on power measurements for $f > 800$ MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to *NORM_{x,y,z}* * *ConvF* whereby the uncertainty corresponds to that given for *ConvF*. A frequency dependent *ConvF* is used in DASY version 4.4 and higher which allows extending the validity from ± 50 MHz to ± 100 MHz.
- *Spherical isotropy (3D deviation from isotropy)*: in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- *Sensor Offset*: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.

ES3DV3 SN: 3149

September 25, 2009

Probe ES3DV3

SN: 3149

Manufactured: June 12, 2007

Calibrated: September 25, 2009

Calibrated for DASY4 System

ES3DV3 SN: 3149

September 25, 2009

DASY – Parameters of Probe: ES3DV3 SN:3149

Sensitivity in Free Space^A

Diode Compression^B

NormX	1.14±10.1%	$\mu\text{V}/(\text{V}/\text{m})^2$	DCP X	94mV
NormY	1.23±10.1%	$\mu\text{V}/(\text{V}/\text{m})^2$	DCP Y	95mV
NormZ	1.29±10.1%	$\mu\text{V}/(\text{V}/\text{m})^2$	DCP Z	91mV

Sensitivity in Tissue Simulating Liquid (Conversion Factors)

Please see Page 8

Boundary Effect

TSL 900MHz Typical SAR gradient: 5% per mm

Sensor Center to Phantom Surface Distance		3.0 mm	4.0 mm
SARbe[%]	Without Correction Algorithm	3.8	1.6
SARbe[%]	With Correction Algorithm	0.8	0.7

TSL 1810MHz Typical SAR gradient: 10% per mm

Sensor Center to Phantom Surface Distance		3.0 mm	4.0 mm
SARbe[%]	Without Correction Algorithm	6.8	3.6
SARbe[%]	With Correction Algorithm	0.4	0.2

Sensor Offset

Probe Tip to Sensor Center 2.0 mm

The reported uncertainty of measurement is stated as the standard uncertainty of Measurement multiplied by the coverage factor $k=2$, which for a normal distribution corresponds to a coverage probability of approximately 95%.

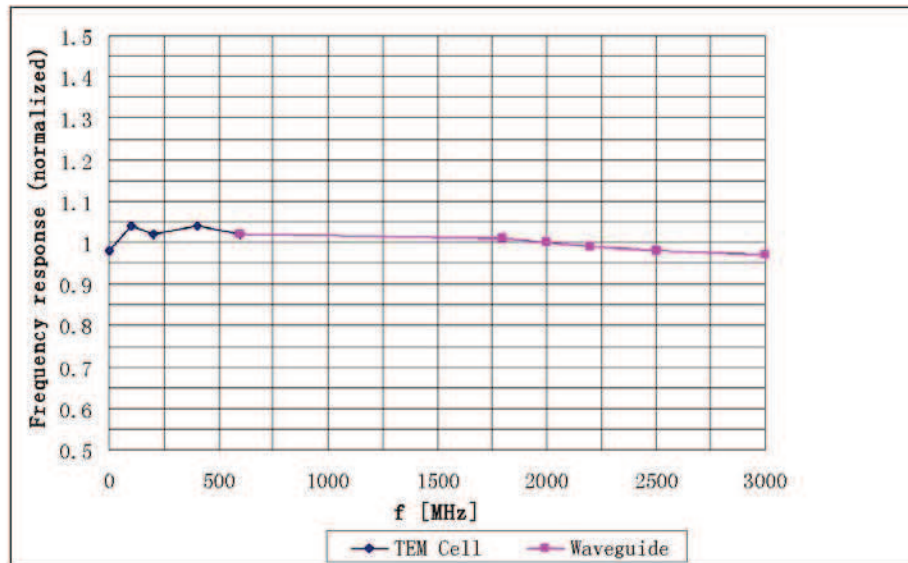
^A The uncertainties of NormX,Y,Z do not affect the E^2 -field uncertainty inside TSL (see Page 8).

^B Numerical linearization parameter: uncertainty not required.

ES3DV3 SN: 3149

September 25, 2009

Frequency Response of E-Field

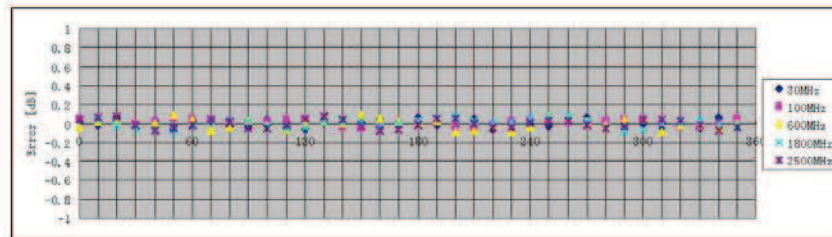
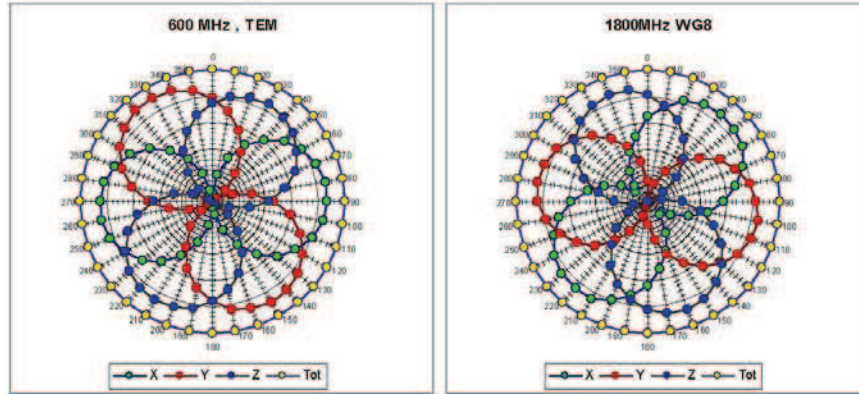


Uncertainty of Frequency Response of E-field: $\pm 5.0\%$ (k=2)

ES3DV3 SN: 3149

September 25, 2009

Receiving Pattern (ϕ), $\theta = 0^\circ$

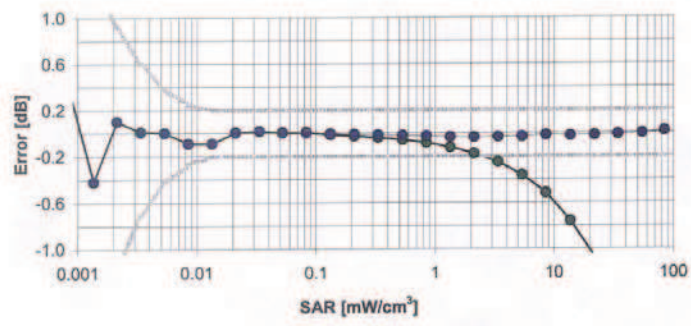
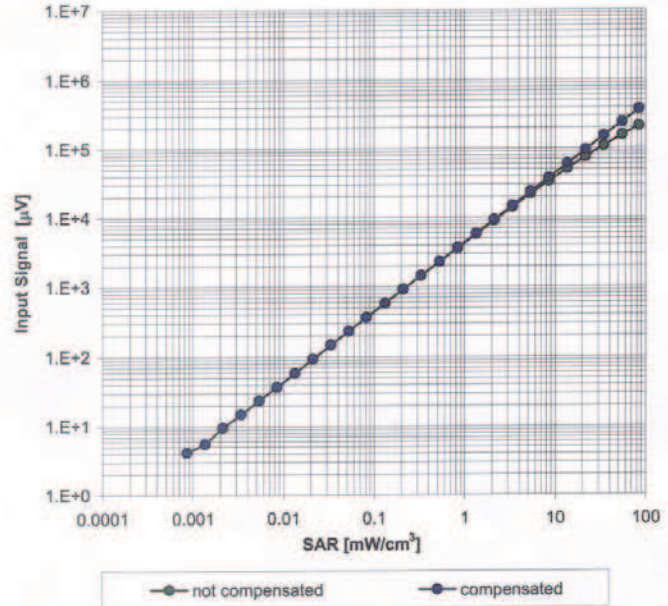


Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ (k=2)

ES3DV3 SN: 3149

September 25, 2009

Dynamic Range $f(\text{SAR}_{\text{head}})$ (Waveguide: WG8, $f = 1800$ MHz)

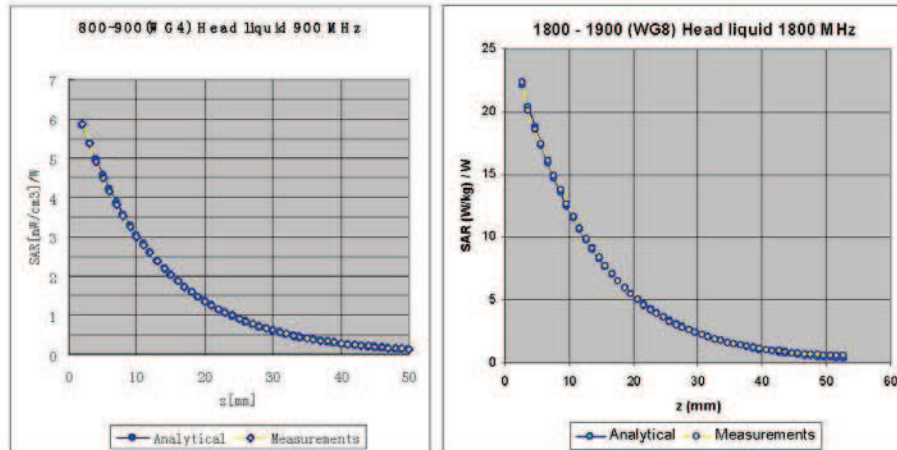


Uncertainty of Linearity Assessment: $\pm 0.5\%$ ($k=2$)

ES3DV3 SN: 3149

September 25, 2009

Conversion Factor Assessment



f[MHz]	Validity[MHz] ^C	TSL	Permittivity	Conductivity	Alpha	Depth	ConvF	Uncertainty
850	±50 / ±100	Head	41.5±5%	0.90±5%	0.91	1.13	6.56	±11.0% (k=2)
900	±50 / ±100	Head	41.5±5%	0.97±5%	0.83	1.26	6.34	±11.0% (k=2)
1800	±50 / ±100	Head	40.0±5%	1.40±5%	0.69	1.47	5.18	±11.0% (k=2)
1900	±50 / ±100	Head	40.0±5%	1.40±5%	0.72	1.38	5.03	±11.0% (k=2)
2100	±50 / ±100	Head	39.8±5%	1.49±5%	0.66	1.34	4.58	±11.0% (k=2)
850	±50 / ±100	Body	55.2±5%	0.97±5%	0.76	1.26	6.22	±11.0% (k=2)
900	±50 / ±100	Body	55.0±5%	1.05±5%	0.99	1.06	6.02	±11.0% (k=2)
1800	±50 / ±100	Body	53.3±5%	1.52±5%	0.75	1.34	4.97	±11.0% (k=2)
1900	±50 / ±100	Body	53.3±5%	1.52±5%	0.62	1.33	4.68	±11.0% (k=2)
2100	±50 / ±100	Body	53.5±5%	1.57±5%	0.68	1.34	4.35	±11.0% (k=2)

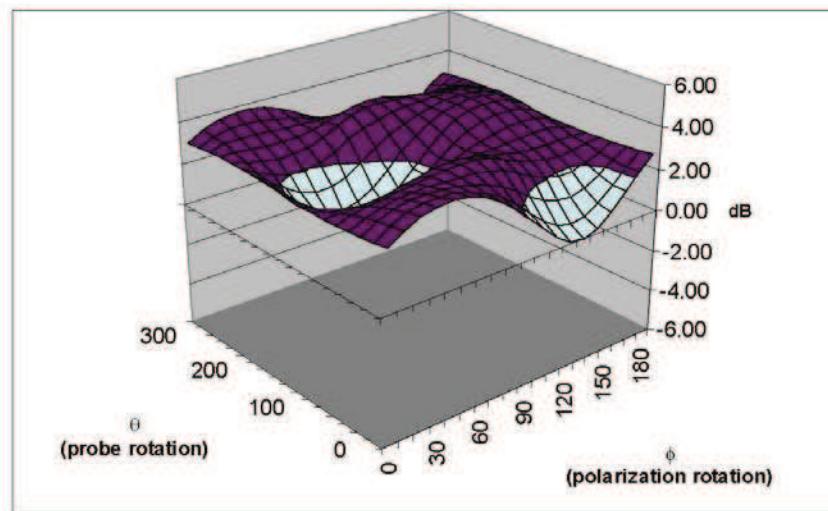
^C The validity of ±100 MHz only applies for DASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

ES3DV3 SN: 3149

September 25, 2009

Deviation from Isotropy

Error (ϕ, θ), $f = 900$ MHz



Uncertainty of Spherical Isotropy Assessment: $\pm 2.5\%$ ($k=2$)

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Accreditation No.: **SCS 108**

Client **TMC China**

Certificate No: **EX3DV4-3617_Jul10**

CALIBRATION CERTIFICATE

Object	EX3DV4-SN: 3617
Calibration procedure(s)	QA CAL-01.v6 Calibration procedure for dosimetric E-field probes
Calibration date:	July 9, 2010
Condition of the calibrated item	In Tolerance

This calibration certify documents the traceability to national standards, which realize the physical units of measurements(SI).
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All calibrations have been conducted at an environment temperature (22±3)°C and humidity<70%

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Reference 30 dB Attenuator	SN:S5129 (30b)	12-Aug-09 (METAS, NO. 251-00404)	Aug-10
DAE4	SN:617	11-Jun-10 (SPEAG, NO.DAE4-907_Jun10)	Jun-11
Reference Probe ES3DV2	SN: 3013	13-Jan-10 (SPEAG, NO. ES3-3013_Jan10)	Jan-11

Secondary Standards	ID#	Check Data (in house)	Scheduled Calibration
RF generator HP8648C	US3642U01700	4-Aug-99(SPEAG, in house check Oct-09)	In house check: Oct-10
Network Analyzer HP 8753E	US37390585	18-Oct-01(SPEAG, in house check Nov-09)	In house check: Nov-10

Calibrated by:	Katja Pokovic	Technical Manager	
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Approved by:	Niels Kuster	Quality Manager	
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Issued: **July 9, 2010**

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Accreditation No.: SCS 108

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ConF	sensitivity in TSL / NORM _{x,y,z}
DCP	diode compression point
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Polarization ϑ	ϑ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., $\vartheta = 0$ is normal to probe axis

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005

Methods Applied and Interpretation of Parameters:

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- **NORM(*f*)_{x,y,z} = NORM_{x,y,z} * frequency_response** (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of *ConvF*.
- **DCP_{x,y,z}:** DCP are numerical linearization parameters assessed based on the data of power sweep (no uncertainty required). DCP does not depend on frequency nor media.
- **ConvF and Boundary Effect Parameters:** Assessed in flat phantom using E-field (or Temperature Transfer Standard for $f \leq 800$ MHz) and inside waveguide using analytical field distributions based on power measurements for $f > 800$ MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORM_{x,y,z} * *ConvF* whereby the uncertainty corresponds to that given for *ConvF*. A frequency dependent *ConvF* is used in DASY version 4.4 and higher which allows extending the validity from ± 50 MHz to ± 100 MHz.
- **Spherical isotropy (3D deviation from isotropy):** in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- **Sensor Offset:** The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.

EX3DV4 SN: 3617

July 9, 2010

Probe EX3DV4

SN: 3617

Manufactured: May 3, 2007

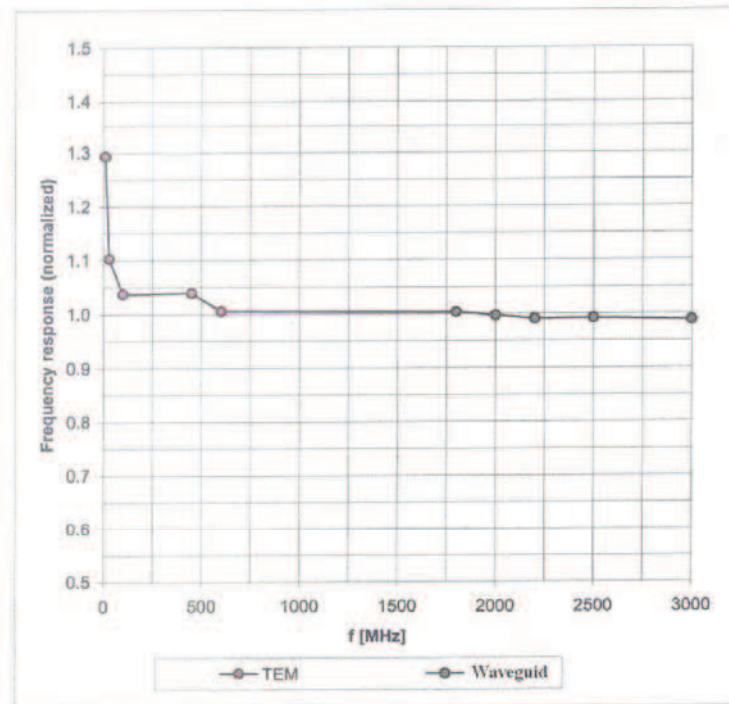
Calibrated: July 9, 2010

Calibrated for DASY4 System

EX3DV4 SN: 3617

July 9, 2010

Frequency Response of E-Field

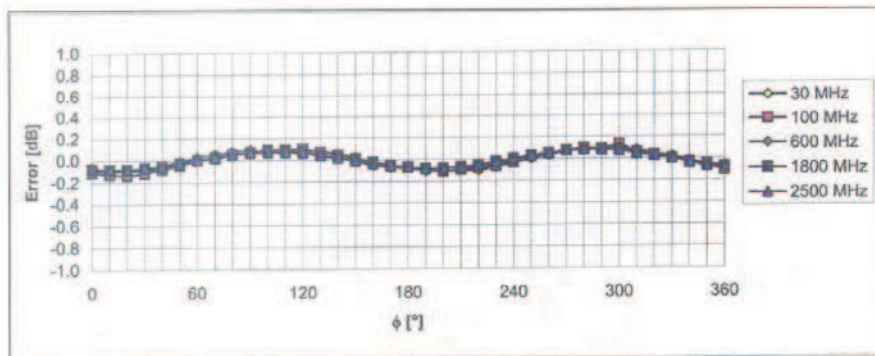
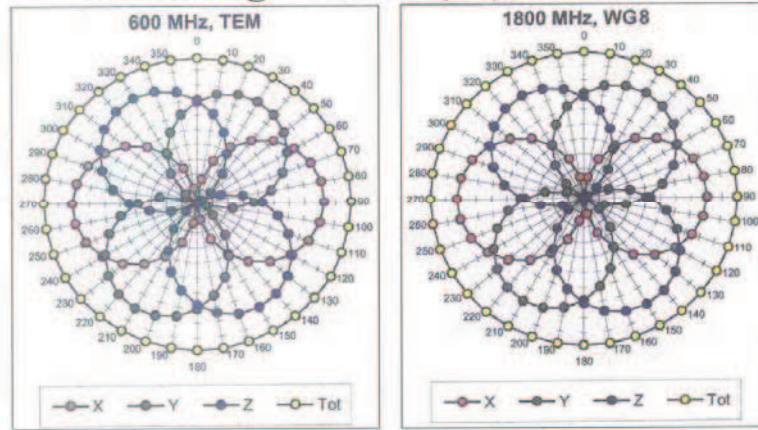


Uncertainty of Frequency Response of E-field: $\pm 6.3\%$ (k=2)

EX3DV4 SN: 3617

July 9, 2010

Receiving Pattern (ϕ), $\theta = 0^\circ$

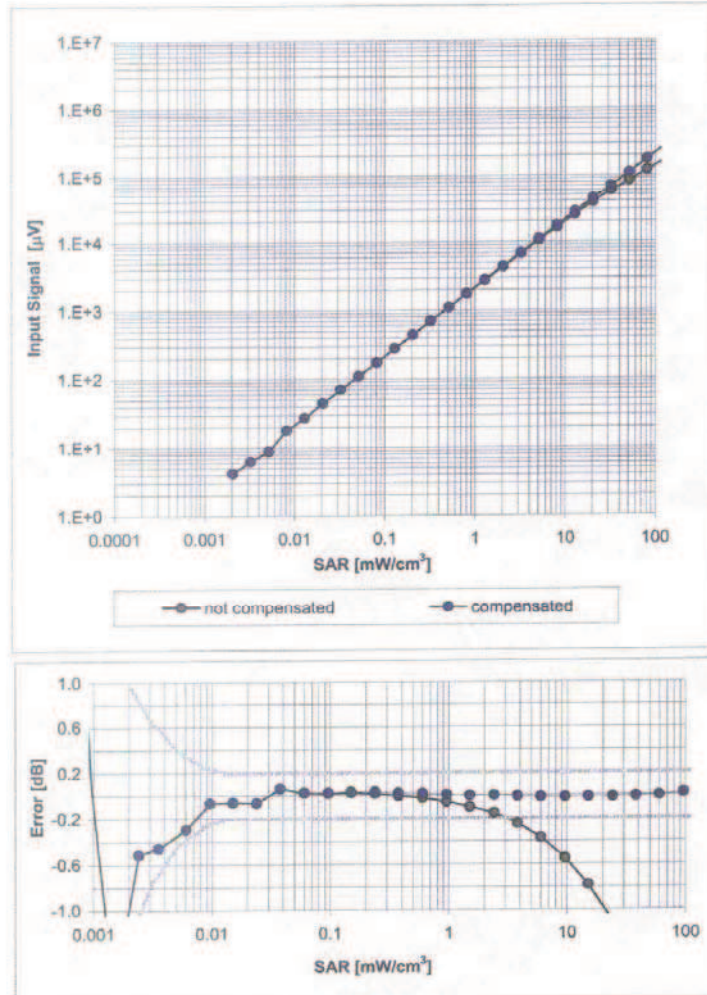


Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ ($k=2$)

EX3DV4 SN: 3617

July 9, 2010

Dynamic Range f(SAR_{head}) (Waveguide: WG8, f = 1800 MHz)

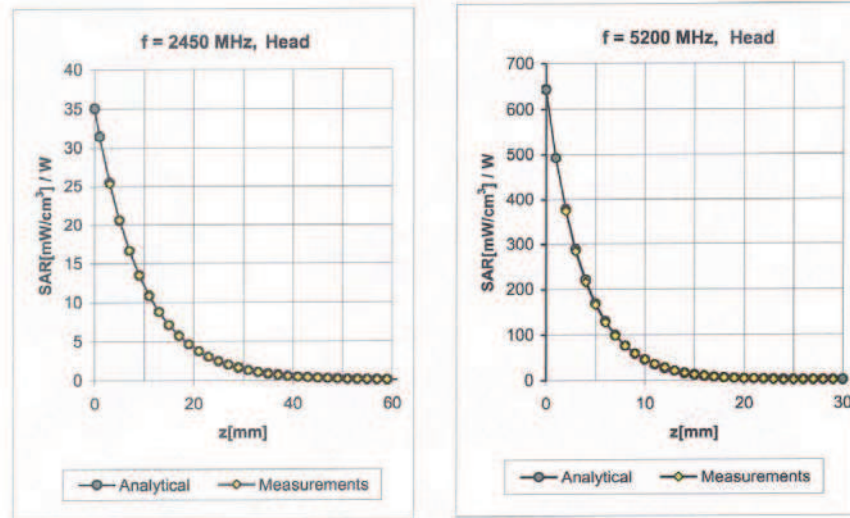


Uncertainty of Linearity Assessment: $\pm 0.6\%$ (k=2)

EX3DV4 SN: 3617

July 9, 2010

Conversion Factor Assessment



f [MHz]	Validity [MHz] ^C	TSL	Permittivity	Conductivity	Alpha	Depth	ConvF	Uncertainty
2300	± 50 / ± 100	Head	39.5 ± 5%	1.67 ± 5%	0.33	1.02	7.23	± 11.8% (k=2)
2450	± 50 / ± 100	Head	39.2 ± 5%	1.80 ± 5%	0.33	1.00	7.19	± 11.8% (k=2)
2600	± 50 / ± 100	Head	39.0 ± 5%	1.96 ± 5%	0.36	1.21	7.16	± 11.8% (k=2)
3500	± 50 / ± 100	Head	37.9 ± 5%	2.91 ± 5%	0.34	1.35	6.48	± 11.8% (k=2)
5200	± 50 / ± 100	Head	36.0 ± 5%	4.66 ± 5%	0.35	1.60	5.33	± 13.1% (k=2)
5800	± 50 / ± 100	Head	35.3 ± 5%	5.27 ± 5%	0.35	1.60	4.69	± 13.1% (k=2)
2300	± 50 / ± 100	Body	52.8 ± 5%	1.85 ± 5%	0.30	1.01	6.95	± 11.8% (k=2)
2450	± 50 / ± 100	Body	52.7 ± 5%	1.95 ± 5%	0.36	1.00	6.88	± 11.8% (k=2)
2600	± 50 / ± 100	Body	52.5 ± 5%	2.16 ± 5%	0.36	1.05	6.84	± 11.8% (k=2)
3500	± 50 / ± 100	Body	51.3 ± 5%	3.30 ± 5%	0.33	1.40	5.02	± 11.8% (k=2)
5200	± 50 / ± 100	Body	49.0 ± 5%	5.30 ± 5%	0.35	1.70	4.64	± 13.1% (k=2)
5800	± 50 / ± 100	Body	48.2 ± 5%	6.00 ± 5%	0.30	1.70	4.53	± 13.1% (k=2)

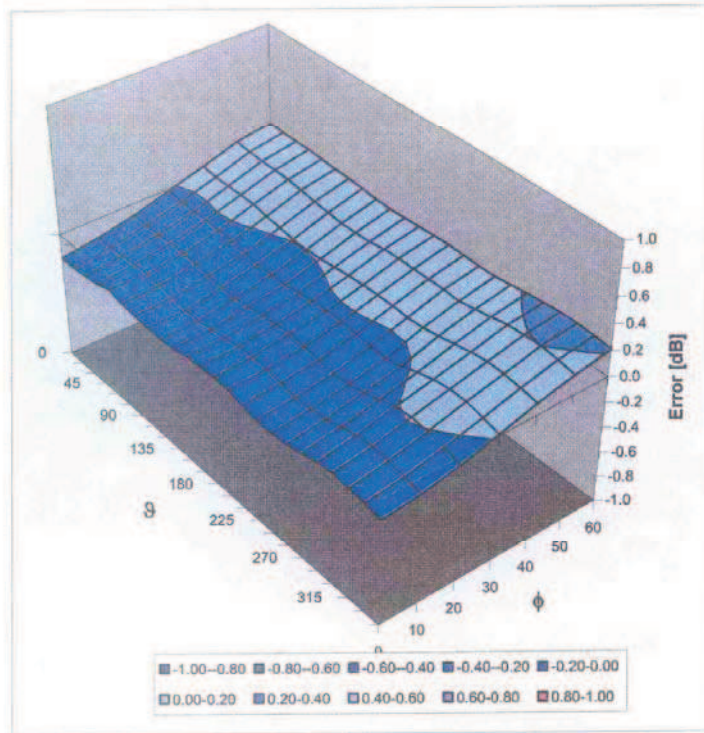
^C The validity of ±100 MHz only applies for DASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

EX3DV4 SN: 3617

July 9, 2010

Deviation from Isotropy

Error (ϕ, θ), $f = 900$ MHz





Uncertainty of Spherical Isotropy Assessment: $\pm 2.6\%$ ($k=2$)


ANNEX F DIPOLE CALIBRATION CERTIFICATE

835 MHz Dipole Calibration Certificate

工业和信息化部通信计量中心
Telecommunication Metrology Center of MIIT







校准
CNAS L0442

Client **TMC** Certificate No: **D835V2-443_Feb10**

CALIBRATION CERTIFICATE

Object: **D835V2 - SN: 443**

Calibration Procedure(s): **TMC-XZ-01-027
Calibration procedure for dipole validation kits**

Calibration date: **February 26, 2010**

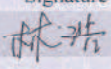
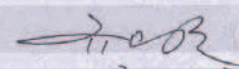
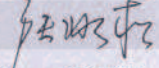
Condition of the calibrated item: **In Tolerance**

This calibration Certificate documents the traceability to national standards, which realize the physical units of measurements(SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature(22±3)°C and humidity<70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date(Calibrated by, Certificate No.)	Scheduled Calibration
Power Meter NRVD	101253	04-Sep-09 (TMC, No.JZ09-248)	Jun-10
Power sensor NRV-Z5	100333	04-Sep-09 (TMC, No. JZ09-248)	Jun-10
Reference Probe ES3DV3	SN 3149	25-Sep-09(SPEAG, No.ES3-3149_Sep09)	Sep-10
DAE4	SN 771	19-Nov-09(SPEAG, No.DAE4-771_Nov09)	Nov-10
RF generator E4438C	MY45092879	18-Jun-09(TMC, No.JZ09-302)	Jun-10
Network Analyzer 8753E	US38433212	29-Aug-09(TMC, No.JZ09-056)	Aug-10

	Name	Function	Signature
Calibrated by:	Lin Hao	SAR Test Engineer	
Reviewed by:	Qi Dianyuan	SAR Project Leader	
Approved by:	Lu Bingsong	Deputy Director of the laboratory	

Issued: February 26, 2010

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Certificate No: D835V2-443_Feb10

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